

•General Description

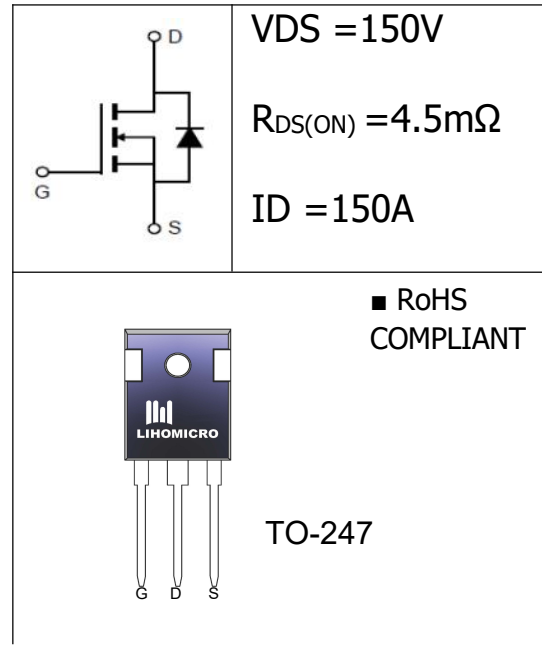
The N-Channel MOSFET LH043N150 has the low $R_{DS(on)}$, low gate charge, fast switching and excellent avalanche characteristics. This device is suitable for fast charge and lighting.

•Features

- Extremely low on-resistance $R_{DS(ON)}$
- Low Switching Charge
- Fully Characterized Capacitance and Avalance

•Application

- BLDC Motor control and drive
- Power Supplies
- DC/DC Converters


•Ordering Information:

Part Number	LH043N150
Package	TO-247
Basic Ordering Unit (pcs)	450
Normal Package Material Ordering Code	LH043N150T2-TO247-TU
Halogen Free Ordering Code	LH043N150T2-TO247-TU-HF

•Absolute Maximum Ratings (TC =25℃)

PARAMETER	SYMBOL	Value	UNIT
Drain-Source Breakdown Voltage	BV_{DSS}	150	V
Gate-Source Voltage	V_{GS}	±20	V
Continuous Drain Current, $T_C = 25^\circ\text{C}$	I_D	150	A
Pulsed drain current ($T_C = 25^\circ\text{C}$, t_p limited by T_{jmax}) ¹	I_D pulse	450	A
Single Pulse Avalanche Energy ²	E_{AS}	1260	mJ
Power Dissipation($T_C=25^\circ\text{C}$)	P_D	220	W
Operating Temperature	T_J	-55~+150	℃
Storage Temperature	T_{STG}	-55~+150	℃

●Electronic Characteristics

PARAMETER	SYMBOL	TEST CONDITION	MIN	TYP	MAX	UNIT
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	150	--	--	V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2.0	3.0	4.0	V
Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=20A$	--	4.3	5.2	mΩ
		$V_{GS}=6V, I_D=20A$	--	5.5	6.8	
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=132V, V_{GS}=0V, T_J=25^{\circ}C$	--	--	1	μA
		$V_{DS}=132V, V_{GS}=0V, T_J=125^{\circ}C$	--	--	10	
Gate-Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	--	--	±100	nA
Gate Resistance	R_g	$f=1MHz, \text{Open Drain}$	--	2.5	--	Ω
Forward Transconductance	G_{fs}	$V_{DS}=5V, I_{DS}=50A$	--	88	--	S
Input Capacitance	C_{iss}	$V_{GS}=0V, V_{DS}=60V, f=1.0MHz$	--	8240	--	pF
Output Capacitance	C_{oss}		--	520	--	
Reverse transfer Capacitance	C_{rss}		--	18	--	
Turn-on delay time	$T_{d(on)}$	$V_{DS}=60V, V_{GS}=10V, I_D=20A$	--	15	--	nS
Rise time	T_r		--	105	--	
Turn -Off Delay Time	$T_{d(off)}$		--	56	--	
Fall time	T_f		--	97	--	
Total Gate Charge	Q_g	$I_D=20A, V_{DS}=60V, V_{GS}=10V$	--	68	---	nC
Gate-to-Source Charge	Q_{gs}		--	24	--	
Gate-to-Drain Charge	Q_{gd}		--	15	---	
Continuous Diode Forward Current	I_S	--	--	--	150	A
Diode Forward Voltage	V_{SD}	$T_J=25^{\circ}C, I_S=50A, V_{GS}=0V$	--	--	1.2	V

●Thermal Characteristics

PARAMETER	SYMBOL	MAX	UNIT
Thermal Resistance Junction-case	R_{thJC}	0.56	°C/W
Thermal Resistance Junction-ambient	R_{thJA}	62.5	°C/W

Notes:

1.Repetitive Rating: Pulse width limited by maximum junction temperature.

2. $I_{AS}=50A, V_{DD}=60V, L=1mH, R_G=50\Omega, \text{Starting } T_J=25^{\circ}C$

•Typical Characteristics

Fig.1 Output Characteristics

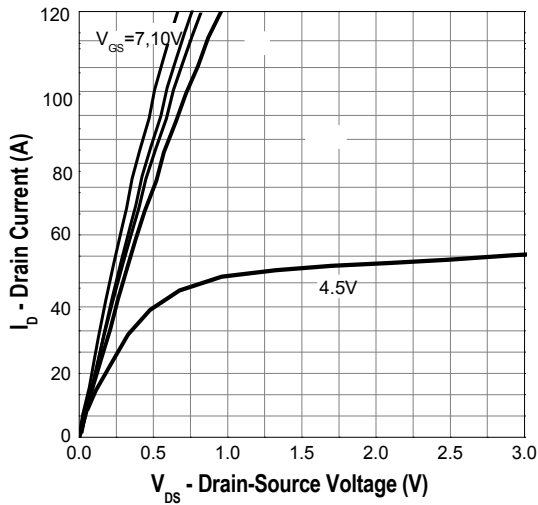


Fig.2 Gate Threshold Voltage

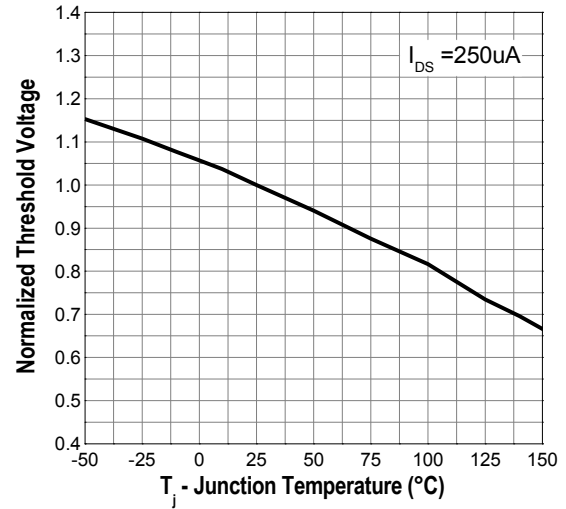


Fig.3 Gate-Source On Resistance

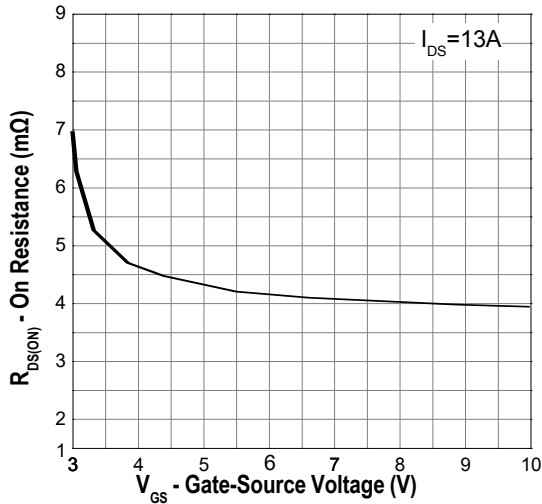


Fig.4 Drain-Source On Resistance

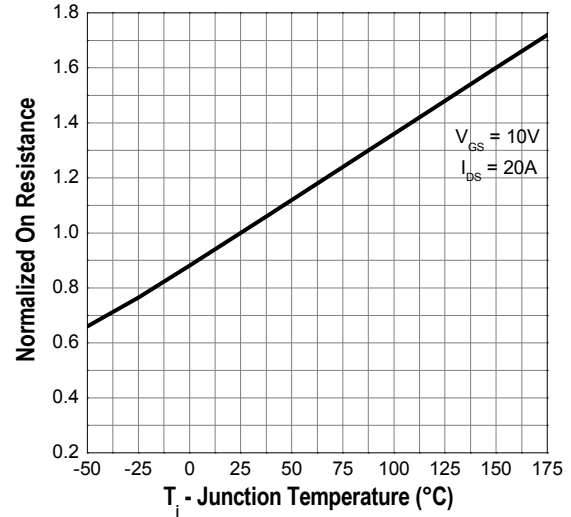


Fig.5 Dource-Drain Forward Characteristics

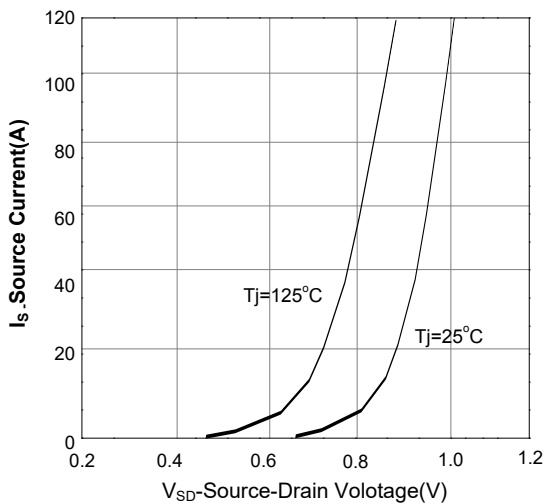
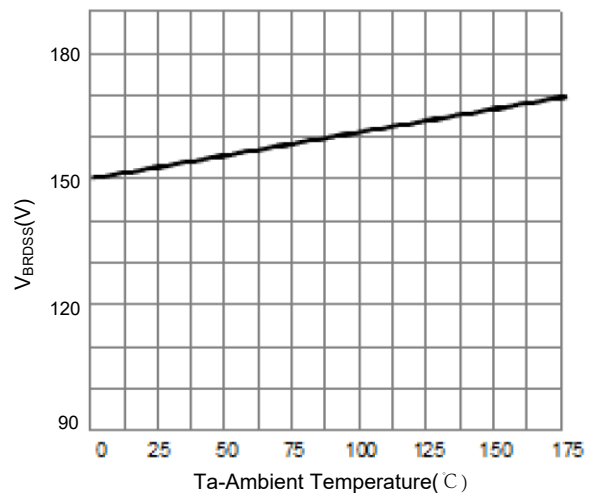


Fig.6 Drain-Source Breakdown Voltage



● **Typical Characteristics**(cont.)

Fig.7 Power Dissipation

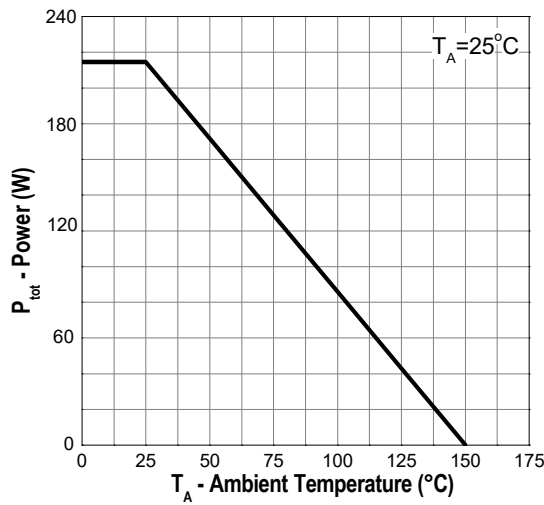


Fig.8 Drain Current

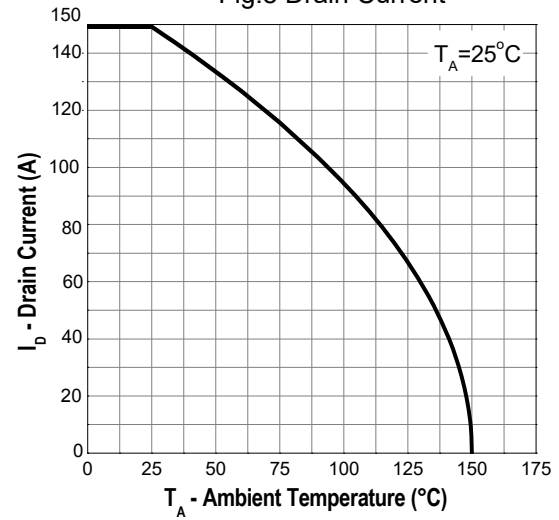


Fig.11 Capacitance

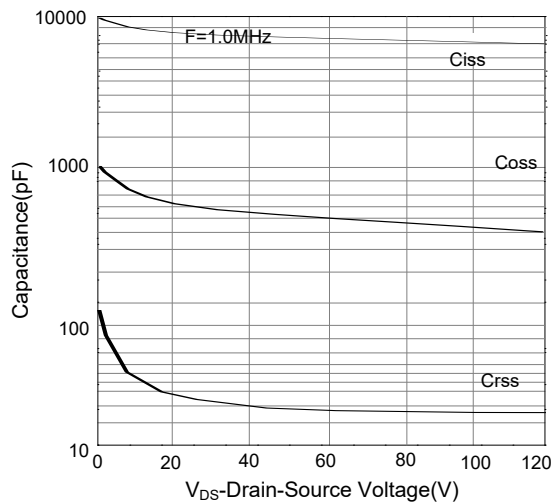


Fig.12 Gate Charge

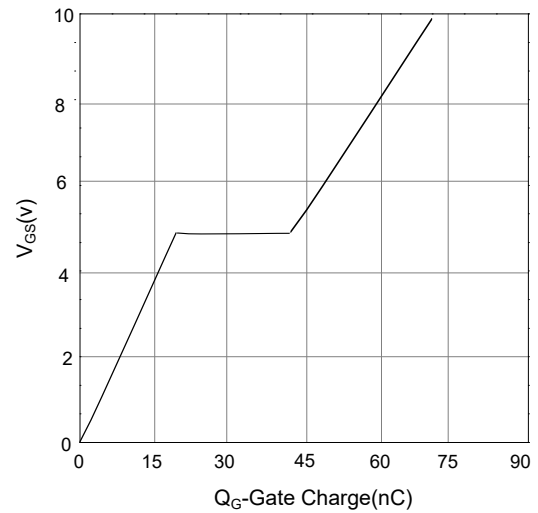


Fig.11 Safe Operation Area

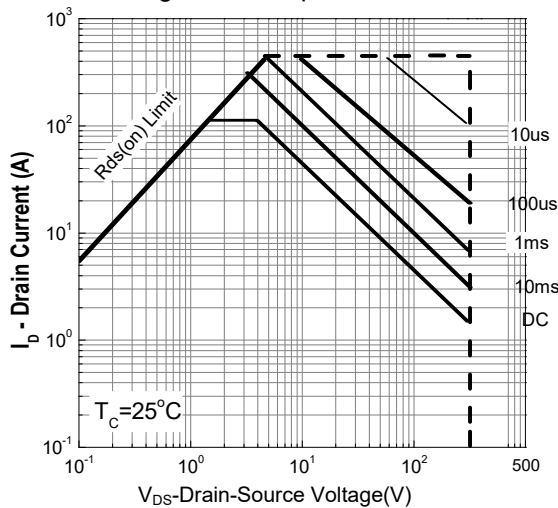
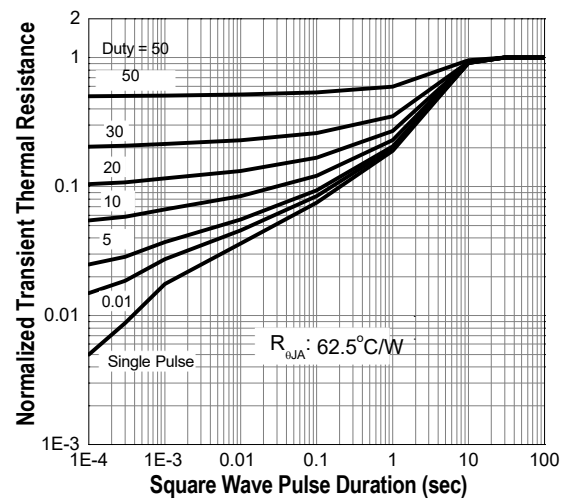
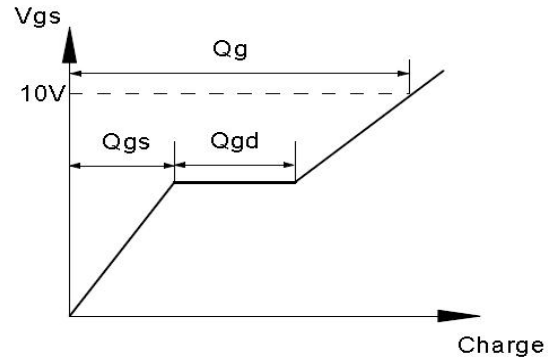
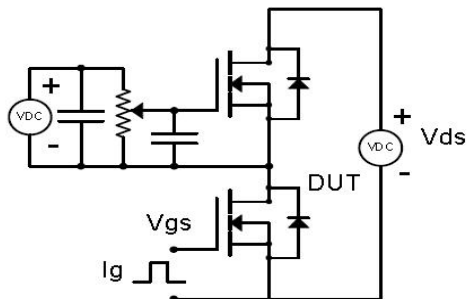


Fig.12 Transient Thermal Impedance

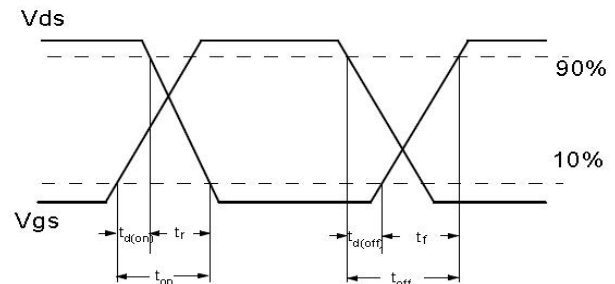
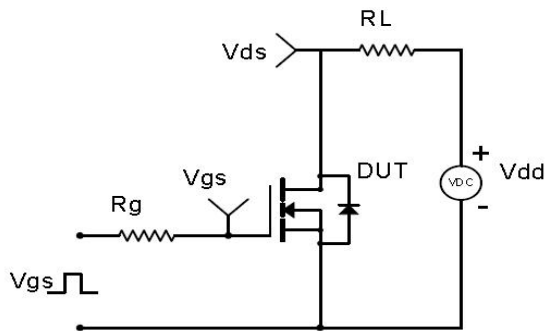


• Test Circuits & Waveforms

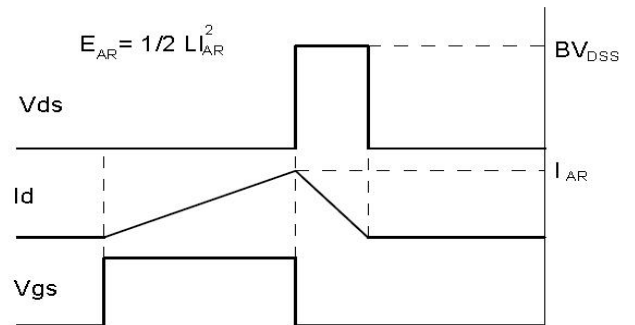
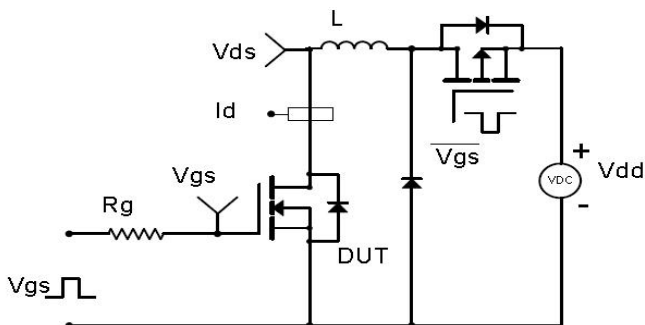
Gate Charge Test Circuit & Waveform



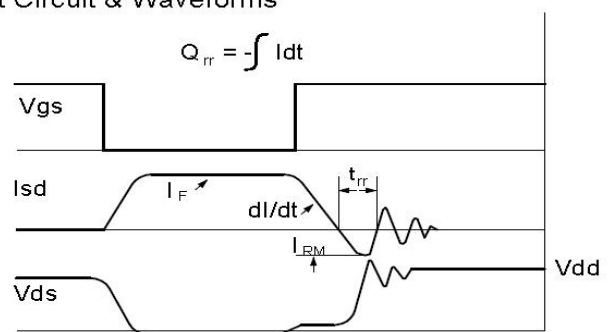
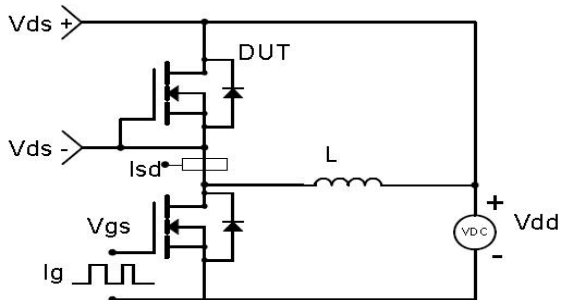
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



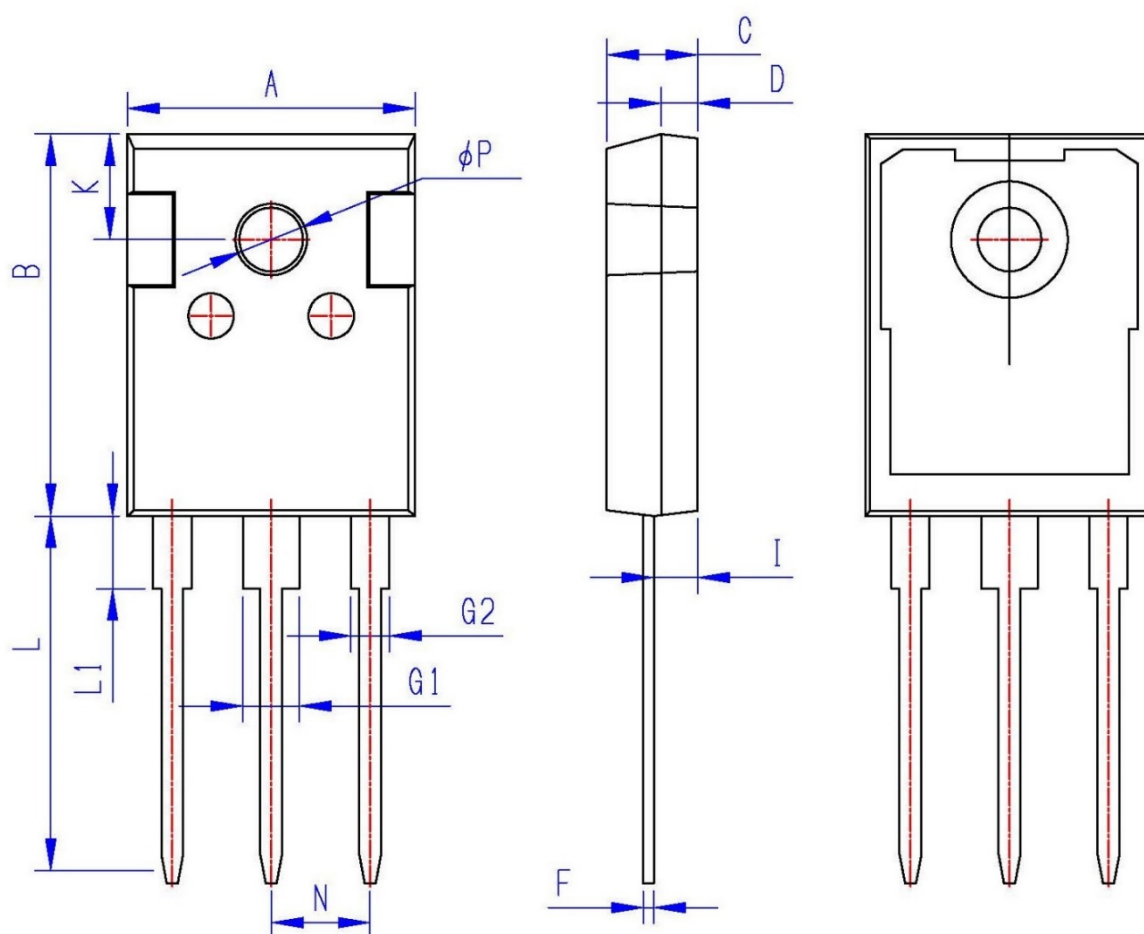
Diode Recovery Test Circuit & Waveforms



●Dimensions (TO-247)

UNIT:mm

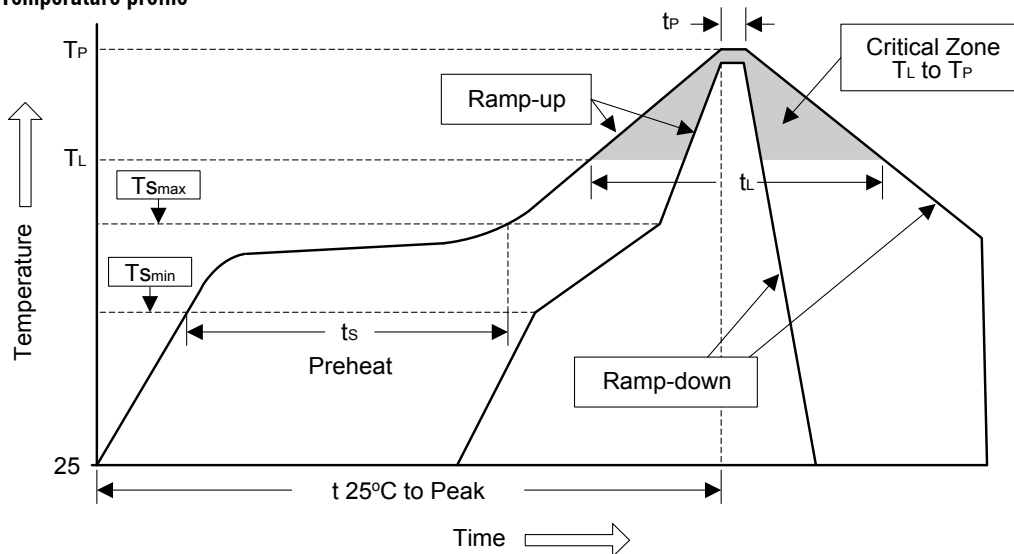
SYMBOL	min	max	SYMBOL	min	max
A	15.60	16.00	G2	1.95	2.25
B	20.80	21.20	N	5.25	5.65
C	4.85	5.15	L1	4.00	4.30
D	1.85	2.15	L	19.60	20.40
E	1.00	1.40	I	2.30	2.50
F	0.50	0.70	ΦP	3.30	3.70
G1	3.00	3.30			



• Soldering Methods for Lihomicro's Products

- 1.Storage environment: Temperature=10°C to 35°C Humidity=65%±15%
- 2.Molder Plastic: UL Flammability Classification Rating 94V-0
- 3.Reflow soldering of surface-mount devices

Figure 1: Temperature profile



● Classification Reflow Profiles

Average ramp-up rate (T_L to T_P)	<3°C/sec	<3°C/sec
Preheat		
- Temperature Min ($T_{S_{min}}$)	100°C	150°C
- Temperature Max ($T_{S_{max}}$)	150°C	200°C
- Time (min to max) (ts)	60 to 120 sec	60 to 180 sec
$T_{S_{max}}$ to T_L		
- Ramp-up Rate	<3°C/sec	<3°C/sec
Time maintained above:		
- Temperature (T_L)	183°C	217°C
- Time (t_L)	60 to 150 sec	60 to 150 sec
Peak Temperature (T_P)	240°C +0/-5°C	260°C +0/-5°C
Time within 5°C of actual Peak Temperature (t_P)	10 to 30 sec	20 to 40 sec
Ramp-down Rate	<6°C/sec	<6°C/sec
Time 25°C to Peak Temperature	<6 minutes	<8 minutes

Flow (wave) soldering (solder dipping)

Products	Peak Temperature	Dipping Time
Pb devices.	245°C ±5°C	5sec ±1sec
Pb-Free devices.	260°C +0/-5°C	5sec ±1sec

● Reliability Test Program

Testitem	Method	Description
Solderability	JESD-22,B102	5sec , 245°C
Holt	JESD-22,A108	1000Hrs,Bias@125°C
PCT	JESD-22,A102	168Hrs,100%RH,2atm,121°C
TCT	JESD-22,A104	500Cycles, -65°C ~150°C